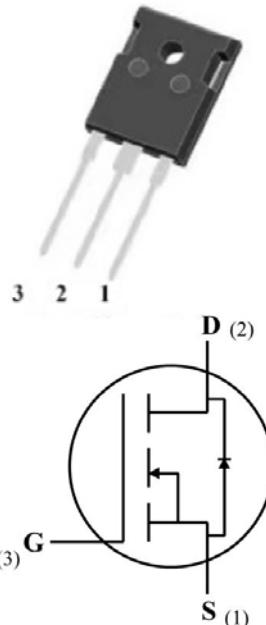


Silicon Carbide Power MOSFET (N-Channel Enhancement)

V _{DS}	1200V
I _{D (25°C)}	38A
R _{DS(on)}	80mΩ



Features

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free, RoHS compliant
- AEC-Q101 qualified

Typical Applications

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

Mechanical Data

- **Package:** TO-247AB
- **Terminals:** Tin plated leads
- **Polarity:** As marked

■ Maximum Ratings (T_c=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	VALUE	TEST CONDITIONS	NOTE
Device marking code				D212080NCTG1Q	
Drain source voltage @ T _j =25°C	V _{DS,max}	V	1200	V _{GS} =0 V, I _D =100uA	
Gate source voltage @ T _j =25°C	V _{GS,max}	V	-8/+22	Absolute maximum values	Note1
Gate source voltage @ T _j =25°C	V _{GS,op}	V	-4/+18	Recommended operational values	Note2
Continuous drain current @ T _c =25°C	I _D	A	38	V _{GS} =18V, T _c =25°C	Fig.18
Continuous drain current @ T _c =100°C			28	V _{GS} =18V, T _c =100°C	
Pulsed drain current	I _{D(pulsed)}	A	80	Pulse width t _p limited by T _{j,max}	Fig.23
Power Dissipation	P _{TOT}	W	220	T _c =25°C , T _j = 175°C	Fig.17
Power Dissipation			94	T _c =110°C, T _j = 175°C	
Operating junction and Storage temperature range	T _j , T _{stg}	°C	-55 to +175		
Soldering temperature	T _L	°C	260	1.6mm (0.063") from case for 10s	
Mounting torque	T _M	Nm	0.6	M3 screw Maximum of mounting process: 3	



YJD212080NCTG1Q

■ Static Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Gate threshold voltage	V _{GS(th)}	V	2.3	2.9	3.6	V _{DS} =V _{GS} , I _D =5mA	Fig.4, 11
				2.2		V _{DS} =V _{GS} , I _D =5mA, Tj=175°C	
Drain source breakdown voltage	V _{(BR)DSS}	V	1200			V _{GS} =0, I _D =100uA	
Zero gate voltage drain current	I _{DSS}	uA		1	10	V _{DS} =1200V, V _{GS} =0V	Fig.16
Gate source leakage current	I _{GSS}	nA			100	V _{GS} = 18V, V _{DS} =0V	
Current drain source on-state resistance	R _{DS ON}	mΩ		77	85	V _{GS} =18V, I _D =20A	Fig.5, 6, 7
				122		V _{GS} =18V, I _D =20A, Tj=175°C	
Internal gate resistance	R _g	Ω		1.5		f=1MHz	
Diode forward voltage	V _{SD}	V		3.9		V _{GS} =-4V, I _{SD} =10A	Fig.8
				3.2		V _{GS} =0V, I _{SD} =10A Tj=175°C	Fig.9
Transconductance	g _f	S		10		V _{DS} =16V, I _D =20A	Fig.4
				9.2		V _{DS} =16V, I _D =20A, Tj=175°C	

■ Dynamic Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Input capacitance	C _{iss}	pF		890		V _{DS} =1000V, V _{GS} =0V, Tj=25°C, f=1MHz, V _{AC} = 25mV	Fig.13, 14
Output capacitance	C _{oss}			58			
Reverse capacitance	C _{rss}			4			
C _{oss} stored energy	E _{oss}	uJ		34			Fig.15
Gate source charge	Q _{gs}	nC		12		V _{DS} =800V, V _{GS} =-4/18V, I _D =20A	Fig.12
Gate drain charge	Q _{gd}			11			
Gate charge	Q _g			41			

■ Switching Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Turn on switching energy	E _{on}	uJ		377		V _{DD} =800V, V _{GS} =-4/+15V, I _D =20A, R _g =0Ω, L=16.7uH	Fig.21, 22
Turn off switching energy	E _{off}			14			
Turn on delay time	t _{d(on)}	ns		21			Fig.21, 22
Rise time	t _r			17			
Turn off delay time	t _{d(off)}	ns		14		V _{DD} =800V, V _{GS} =-4/+15V, I _D =20A, R _g =0Ω, L=16.7uH	Fig.21, 22
Fall time	t _f			8			



■ **Body diode characteristics** (T_c=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Diode forward voltage	V _{SD}	V		3.9		V _{GS} =-4V, I _{SD} =10A	Fig.8
				3.2		V _{GS} =0V, I _{SD} =10A, T _j =175°C	Fig.9
Continuous diode forward current	I _S	A		38		T _c =25°C	Note1
Reverse recovery time	trr	nS		28.24		V _R =800V, V _{GS} =-4V, I _D =20A, dI/dt=2095A/uS	
Reverse recovery charge	Qrr	nC		190			
Peak reverse recovery current	Irrm	A		30.08			

Note 1: When using SiC Body Diode the maximum recommended V_{GS} = -4V

Note 2: MOSFET can also safely operate at 0/18 V

■ **Thermal Characteristics** (T_a=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Value
Thermal resistance	R _{θJ-C}	°C /W	0.68

■ **Typical Characteristics**

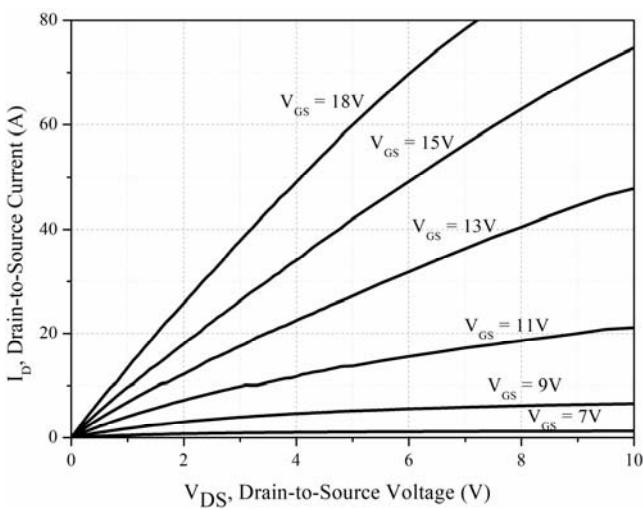


Figure 1. Output Characteristics T_j = -40°C

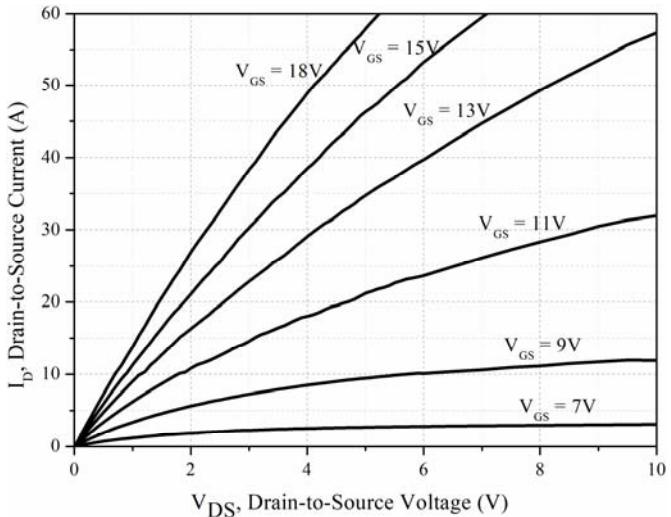


Figure2. Output Characteristics T_j = 25°C

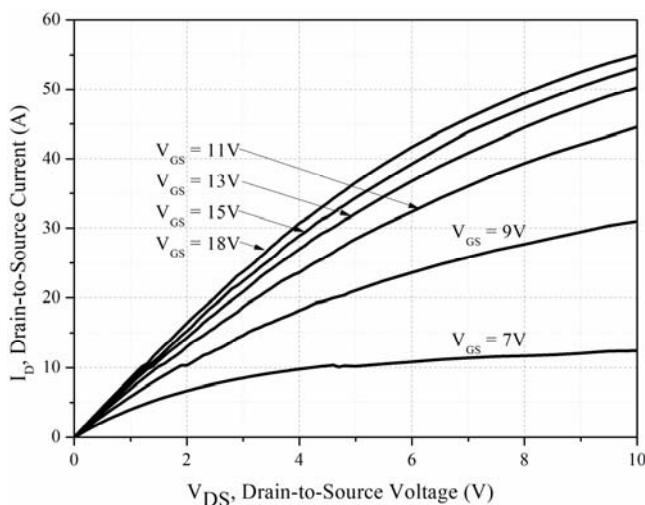


Figure 3. Output Characteristics $T_j = 175^\circ\text{C}$

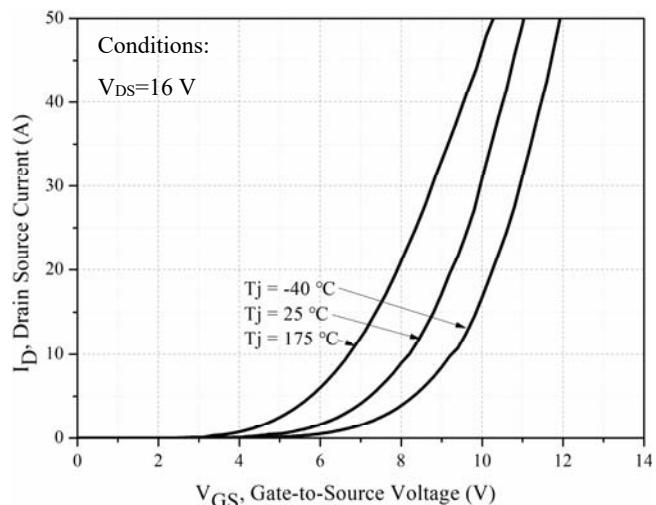


Figure 4. Transfer Characteristics for various junction temperature

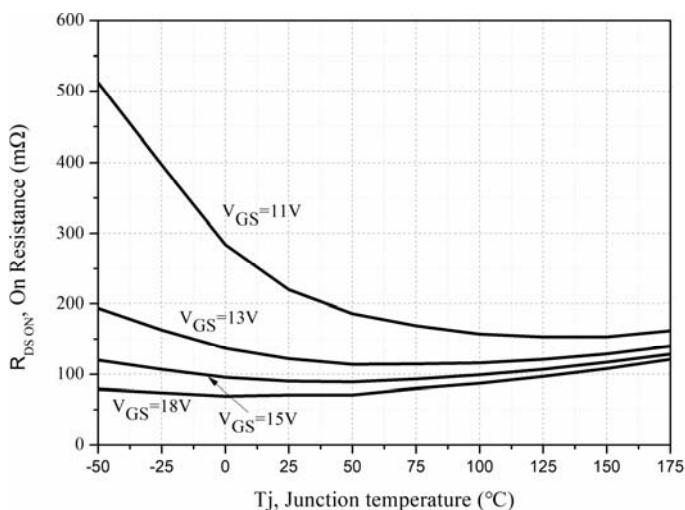


Figure 5. On-resistance vs. temperature for various gate voltage

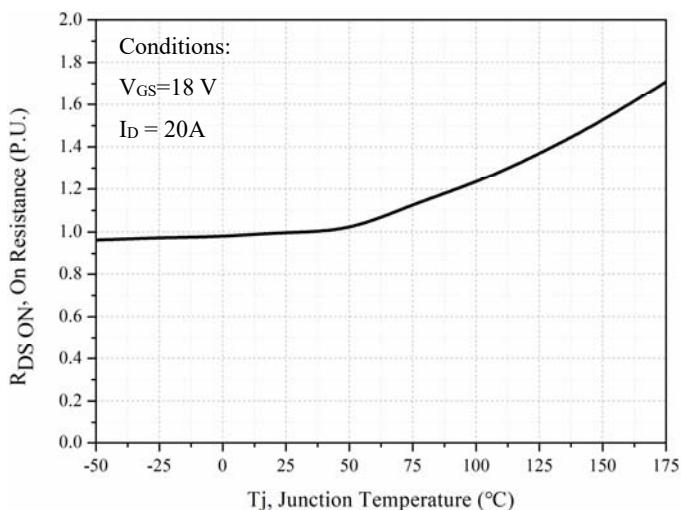


Figure 6. Normalized on-resistance vs. temperature

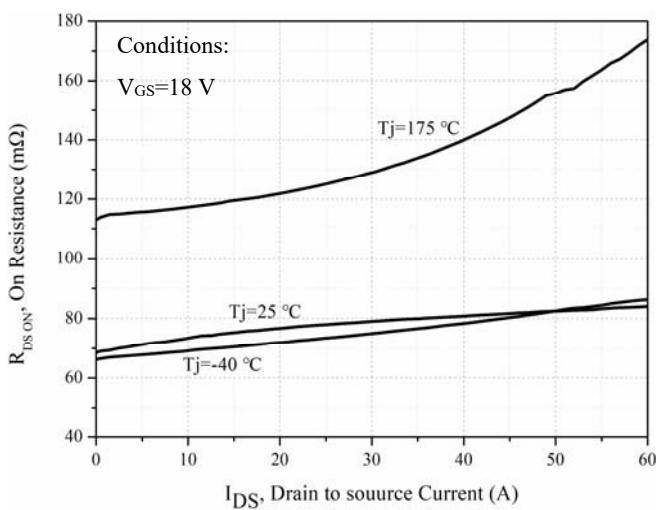


Figure 7. On-resistance vs. drain current

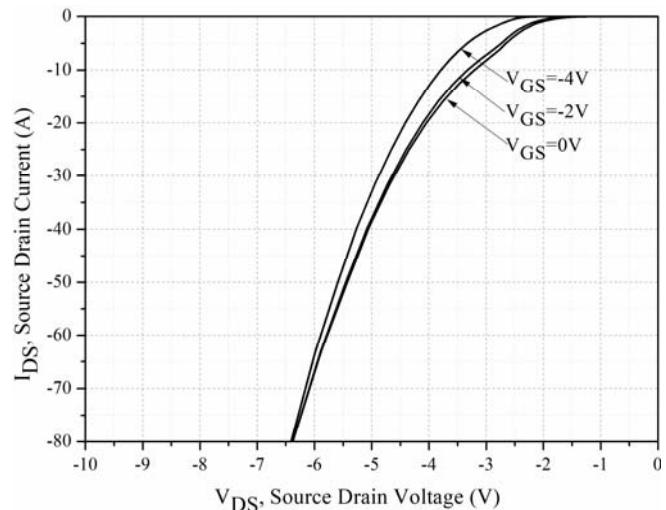


Figure 8. Body diode characteristic at $T_j = 25^\circ\text{C}$



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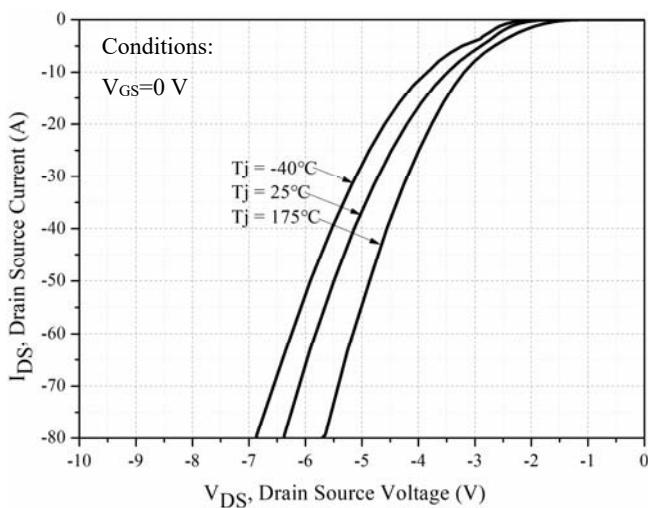


Figure 9. Body diode characteristic

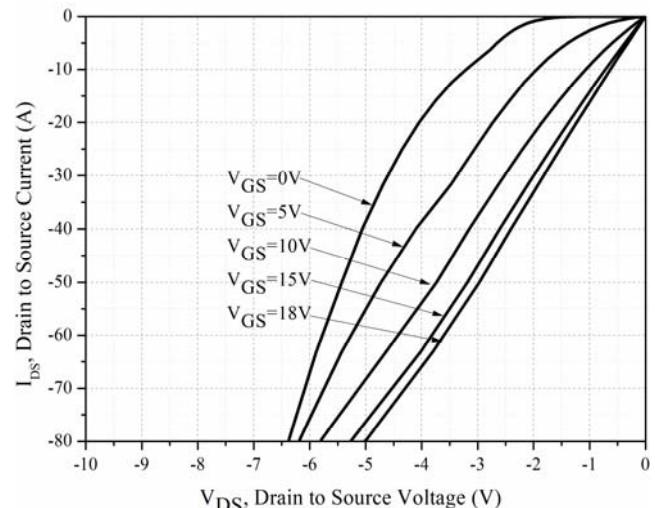


Figure 10. 3rd quadrant characteristic at T_j = 25 °C

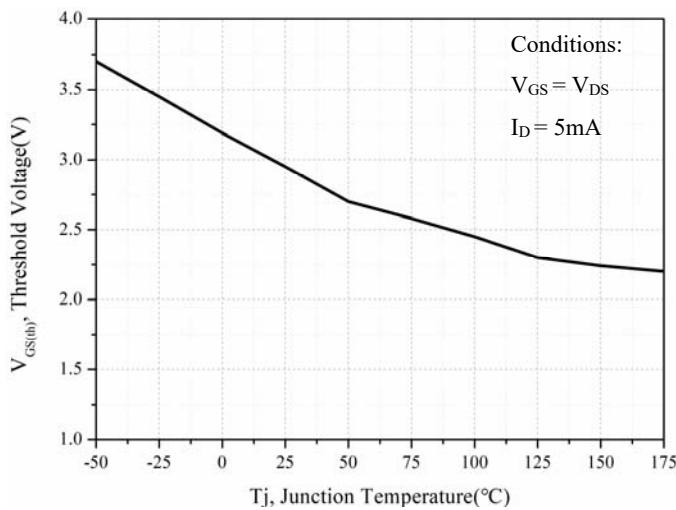


Figure 11. Threshold voltage vs. temperature

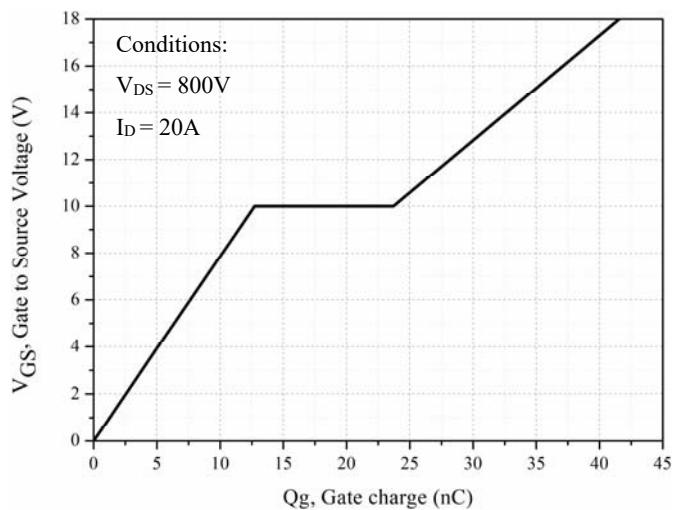


Figure 12. Gate charge characteristic

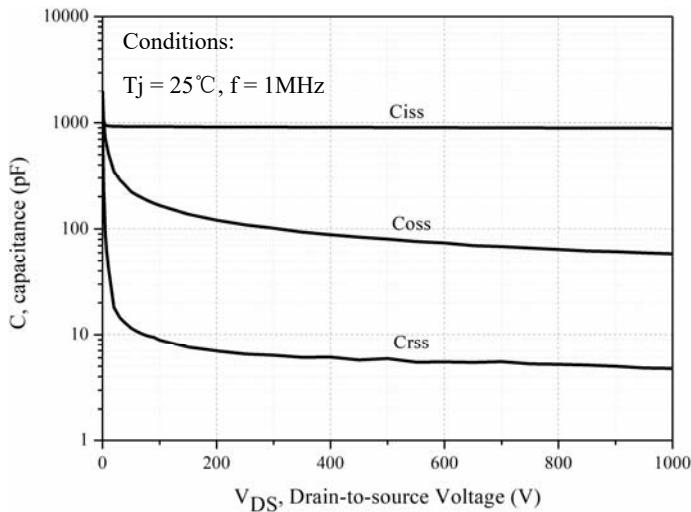


Figure 13. Capacitances vs. drain source voltage (0-1000V)

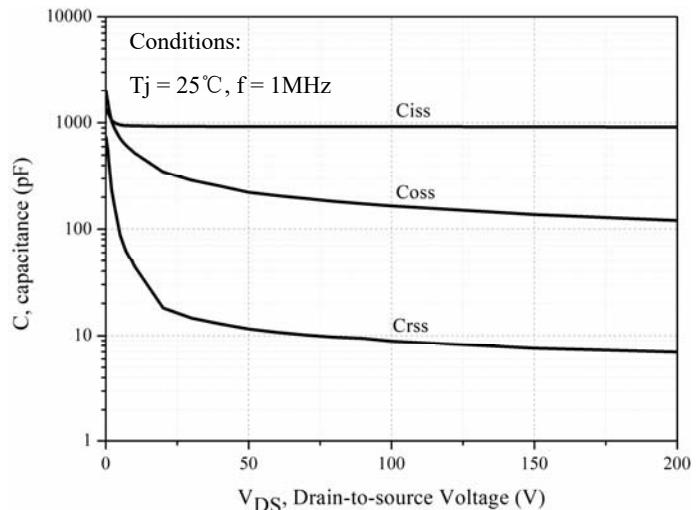
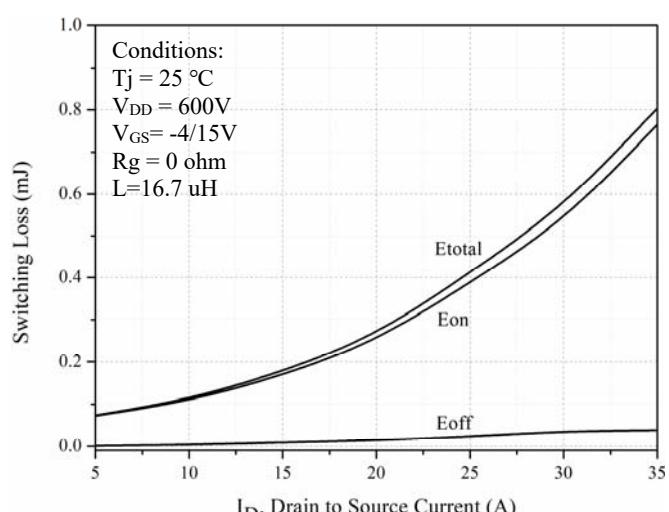
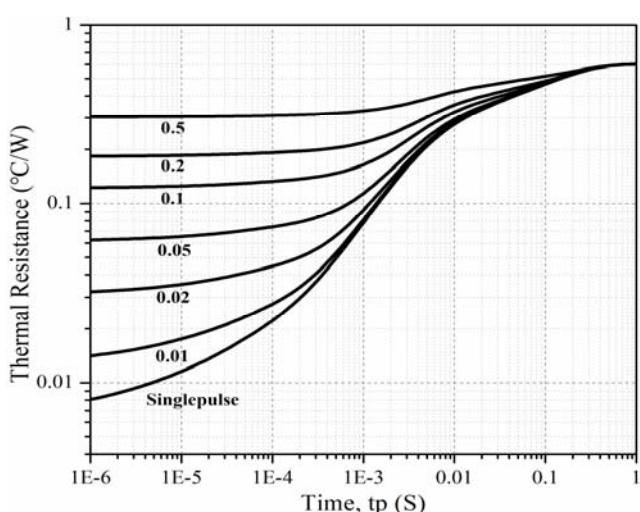
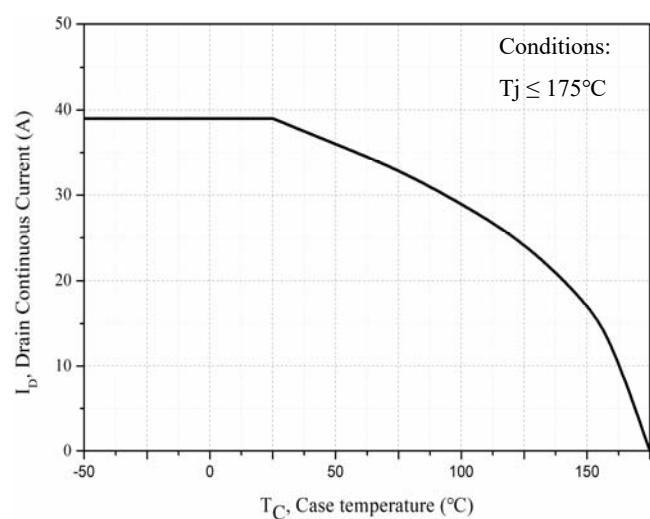
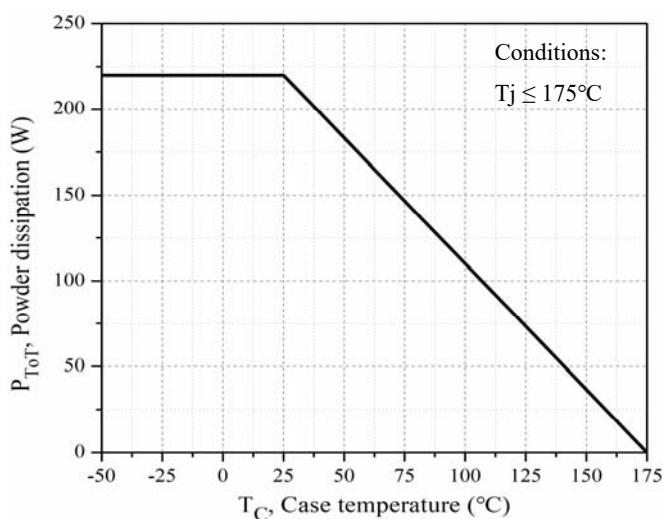
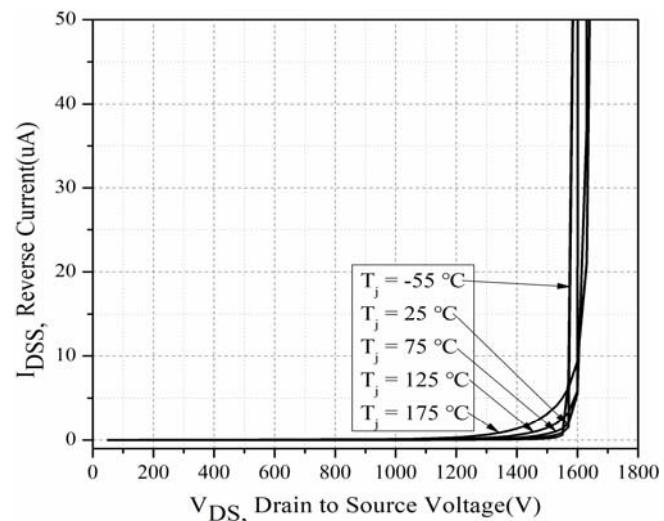
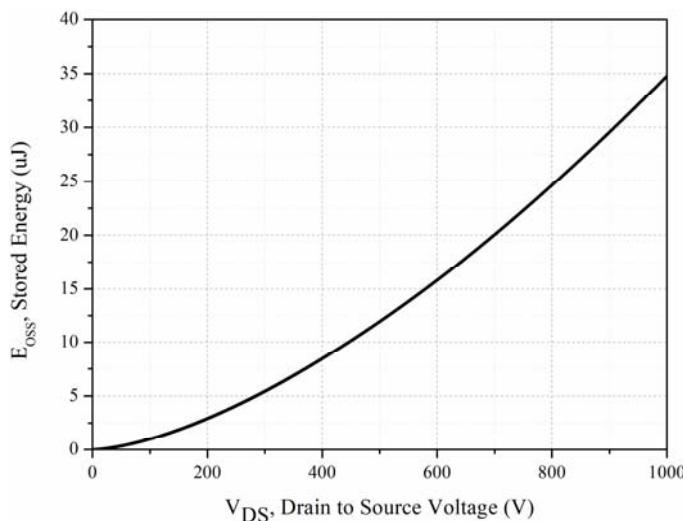


Figure 14. Capacitances vs. drain source voltage (0-200V)



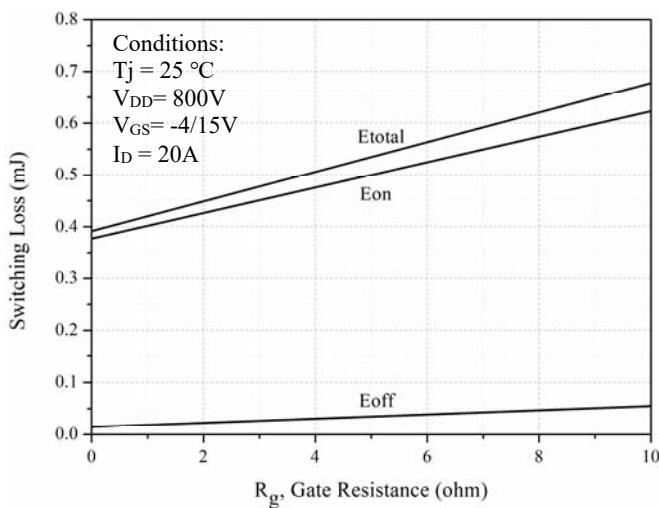


Figure 21. Clamped inductive switching energy vs. R_g

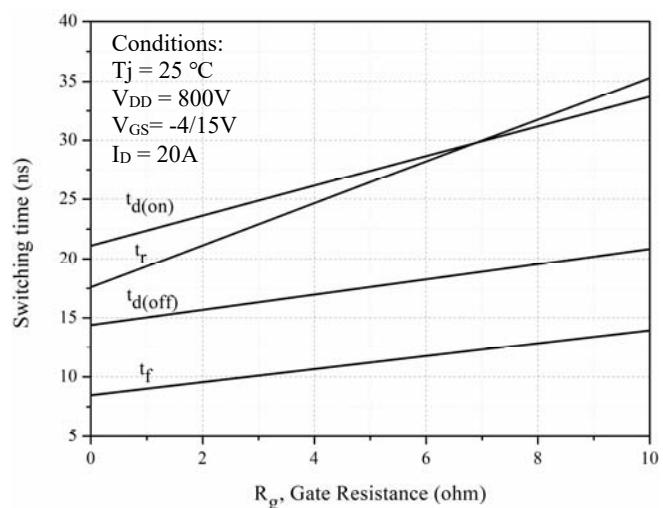


Figure 22. Switching times vs. R_g

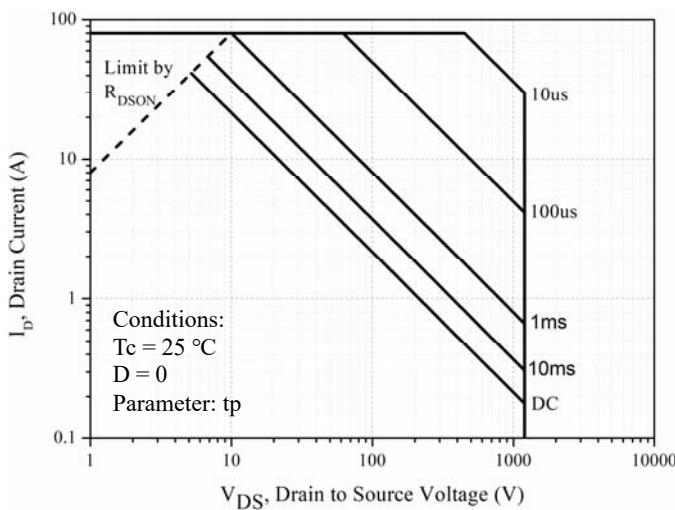


Figure 23. Safe operating area

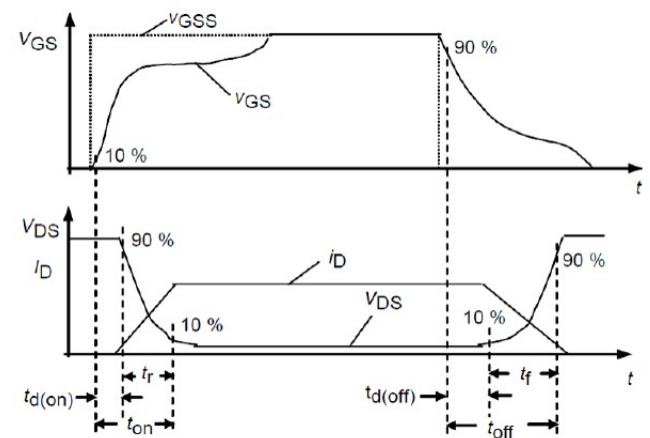


Figure 24. Switching Times Definition

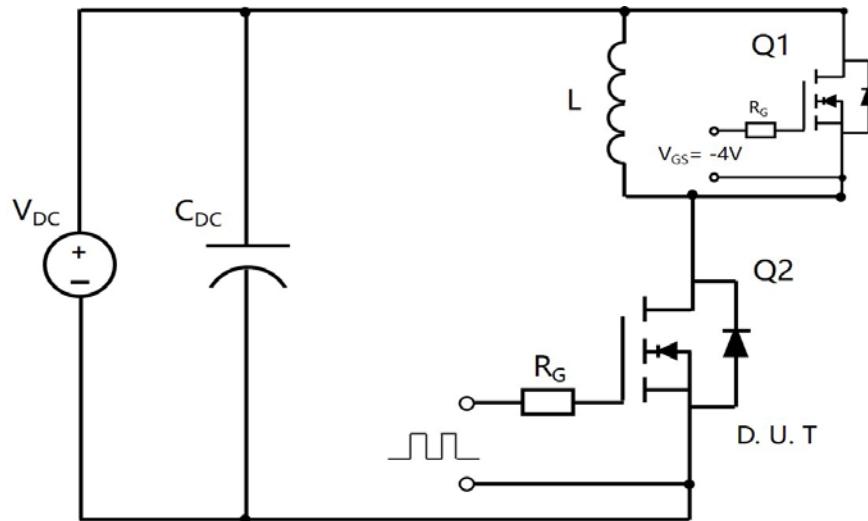
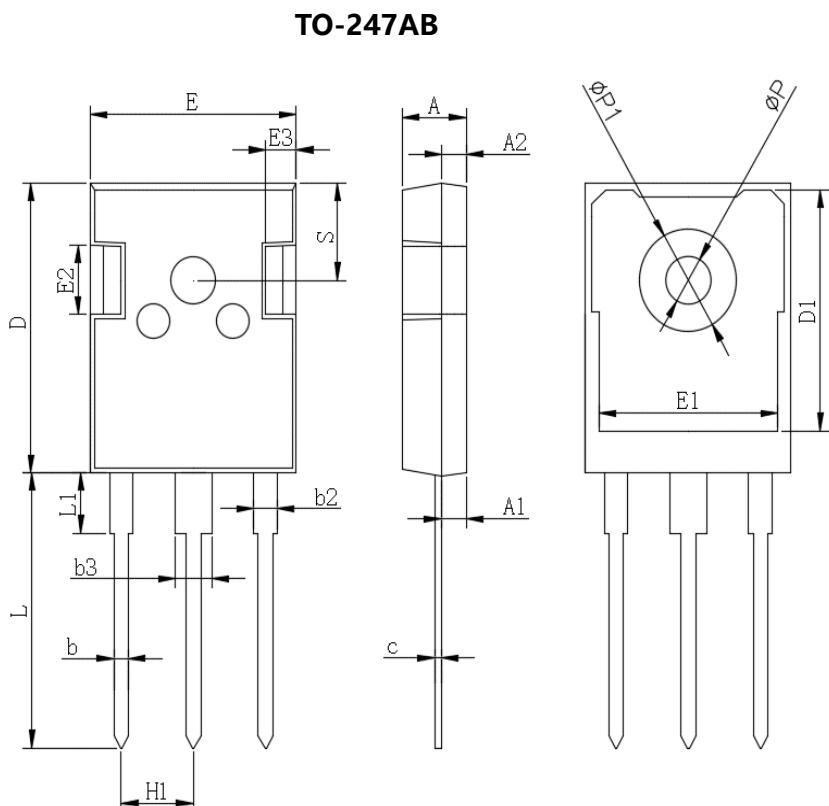


Figure 25. Clamped Inductive Switching Waveform Test Circuit



■Outline Dimensions



TO-247AB		
Dim	Min	Max
A	4.80	5.20
A1	2.21	2.61
A2	1.85	2.15
b	1.0	1.4
b2	1.91	2.21
C	0.5	0.7
D	20.70	21.30
D1	16.25	16.85
E	15.50	16.10
E1	13.0	13.6
E2	4.80	5.20
E3	2.30	2.70
L	19.62	20.22
L1	-	4.30
ΦP	3.40	3.80
ΦP1	-	7.30
S	6.15TYP	
H1	5.44TYP	
b3	2.80	3.20



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